



Product Specification

Domestic Part Number	IRF9952
Overseas Part Number	IRF9952
Equivalent Part Number	IRF9952



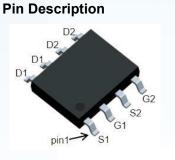
8mΩ(Typ)@VGS=10V	7
GmΩ(Typ)@VGS=-10V	-6
	8mΩ(Typ)@VGS=10V 5mΩ(Typ)@VGS=-10V

FEATURE:

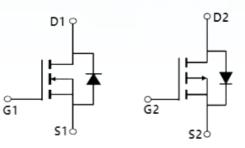
• The IRF9952 is the highest performance trench N-ch and P-ch MOSFETs with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

APPLICATIONS:

- Power management in half bridge and inverters
- DC-DC Converter
- Load Switch







Absolute Maximum Ratings

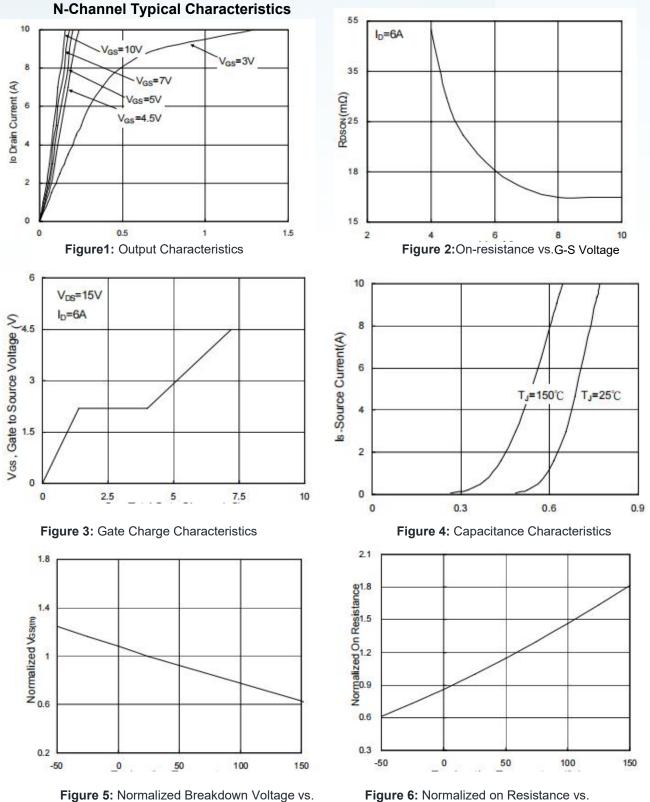
Symbol Parameter			Rat	ing	Unito
Symbol			N-Channel	P-Channel	Units
Vdss	Drain-Source Voltage		30	-30	V
Vgss	Gate-Source Voltage	Gate-Source Voltage			V
lo	Continuous Drain Current(V _{GS=} -4.5V)	T _A =25°C	7	-6	
		T _A =70°C	6	-4	A
TJ	Maximum Junction Temperature	150		°C	
Тѕтс	Storage Temperature Range	-55 to 150		°C	
Ідм	Pulsed Drain Current	20	-12	А	
PD	Maximum Power Dissipation	T _A =25°C			w
		T _A =70°C			vv
Eas	Avalanche Energy, Single Pulsed	72	59	mJ	
RθJC	Thermal Resistance-Junction to Case	50		°C/W	
RθJA	Thermal Resistance-Junction to Ambie	8	5	°C/W	

Symbo I	Parameter	Conditions	Min.	Тур.	Max.	Unit		
Static Characteristics								
BVDSS	Drain-Source Breakdown Voltage	VGS=0V, ID=250uA	30			V		
VGS(th)	Gate threshold voltage	VDS=VGS,ID=250uA	1.0	1.5	2.5	V		
		VGS=10V , ID=6A		18	25	mΩ		
RDS(on)	Drain-Source On-state Resistance	VGS=4.5V , ID=-5A		25	31	mΩ		
IGSS	Gate-source leakage current	VGS=±12V , VDS=0V			±100	Α		
		VDS=20V,VGS=0V,TJ=25 °C			1			
IDSS	Zero gate voltage drain current	TJ=55 ℃			5	μA		
Dynam	ic Characteristic				I			
Ciss	Input Capacitance			370				
Coss	Output Capacitance	VGS=0V, VDS=10V, Frequency=1.0MHz		70		pF		
Crss	Reverse Transfer Capacitance			57				
QG	Gate Total Charge			7.2				
Qgs	Gate-Source charge	VDS=10V, VGS=5V, IDS=3A		1.4		nC		
Qgd	Gate-Drain charge	- 100-3A		2.2				
td(on)	Turn-on delay time			3.9				
tr	Turn-on Rise Time	VDD=10V , VGS=5V ,		9.2				
td(off)	Turn-off Delay Time	RG=5Ω, ID=3A		14.5		ns		
tf	Turn-off Fall Time	-		6.0				
RG	Gate Resistance	VGS=0V,VDS=0V,F=1MH	Hz	2.5		Ω		
Diode Characteristics								
VSD	Diode Forward Voltage	VGS=0V , IS=1A , TJ=25℃			1.2	V		
trr	Reverse Recovery Time	ISD=4.1A,				ns		
Qrr	Reverse Recovery Charge	dISD/dt=-100A/µs				nC		

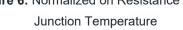
Electrical Characteristics (TA=25°C Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit		
Static C	Static Characteristics							
BVDSS	Drain-Source Breakdown Voltage	VGS=0V, ID=-250uA	-30			V		
VGS(th)	Gate threshold voltage	VDS=VGS,ID=-250uA	-1.0	-1.5	-2.5	V		
		VGS=-10V , ID=-4.5A		36	55	mΩ		
RDS(ON)	DS(ON) Drain-Source On-state Resistance VGS=-4.5V , ID=-5A			50	75	mΩ		
IGSS	Gate-source leakage current	VGS=±12V, VDS=0V			±100	А		
1500		VDS=-20V,VGS=0V,TJ=25℃			-1			
IDSS	Zero gate voltage drain current	TJ=55℃				μA		
Dynami	c Characteristic		1					
Ciss	Input Capacitance			530				
Coss	Output Capacitance	VGS=0V, VDS=-10V, Frequency=1.0MHz		70		pF		
Crss	Reverse Transfer Capacitance			56				
QG	Gate Total Charge			6.8				
Qgs	Gate-Source charge	VDS=-10V, VGS=-5V, IDS=-3A		1.0		nC		
Qgd	Gate-Drain charge			1.4				
td(on)	Turn-on delay time			14				
tr	Turn-on Rise Time	VDD=-10V , VGS=-5V ,		61				
td(off)	Turn-off Delay Time	RG=5Ω, ID=-3A		19		ns		
tf	Turn-off Fall Time			10				
RG	Gate Resistance	VGS=0V,VDS=0V,F=1MHz				Ω		
Diode Characteristics								
VSD	Diode Forward Voltage	VGS=0V , IS=-1A , TJ=25℃			1.2	V		
trr	Reverse Recovery Time	ISD=-4.1A,				ns		
Qrr	Reverse Recovery Charge	dISD/dt=-100A/µs				nC		

Electrical Characteristics (TA=25°C Unless Otherwise Noted)



Junction Temperature



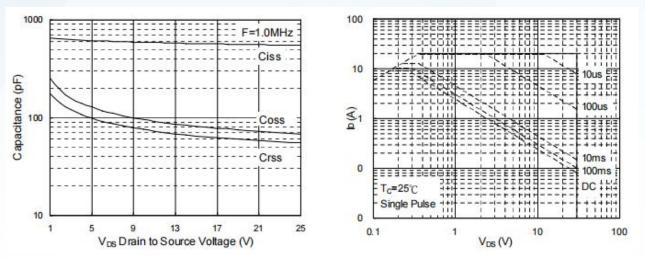


Fig.7 Capacitance

Figure 8: Maximum Safe Operating Area

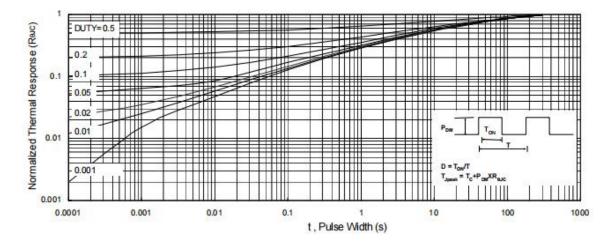
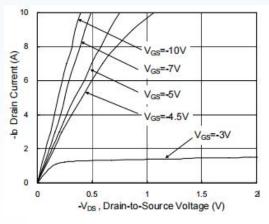
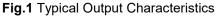
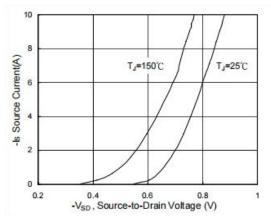


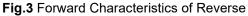
Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

P-Channel Typical Characteristics









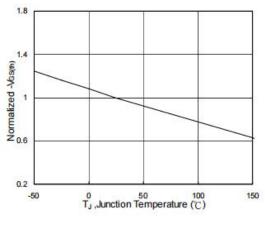


Fig.5 Normalized VGS(th) vs. TJ

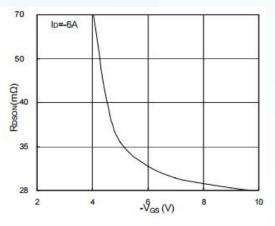
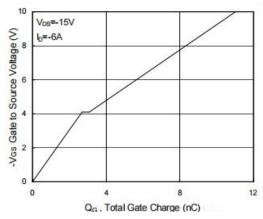
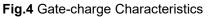


Fig.2 On-Resistance vs. Gate-Source





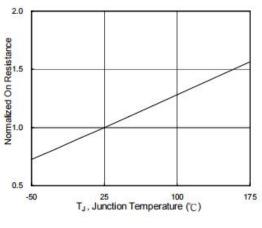


Fig.6 Normalized RDSON vs. TJ

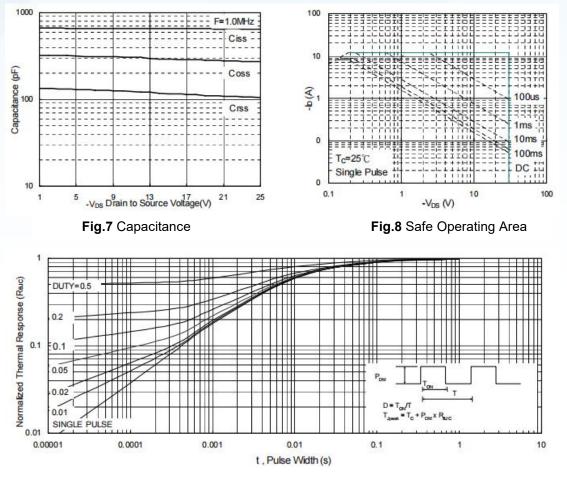
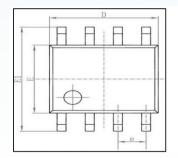
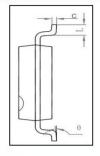
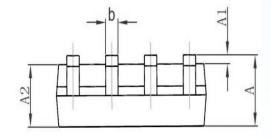


Fig.9 Normalized Maximum Transient Thermal Imp







Sumb a l	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	1.350	1. 750	0. 053	0.069	
A1	0. 100	0. 250	0.004	0.010	
A2	1.350	1.550	0. 053	0.061	
b	0. 330	0. 510	0.013	0.020	
с	0. 170	0. 250	0.006	0.010	
D	4. 700	5. 100	0. 185	0. 200	
E	3.800	4.000	0. 150	0. 157	
E1	5.800	6. 200	0. 228	0. 244	
e	1. 270 (BSC)		0. 050	(BSC)	
L	0. 400	1. 270	0.016	0.050	
θ	0°	8°	0°	8°	



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